Search Notes

Application/Control	Ño.
10/661,534	
Examiner	

Applicant(s)/Patent under Reexamination KATAYAMA ET AL. Art Unit

Devona	F	Faulk
DCVOIIA	L	, aun

2615
------

SEARCHED			
Class	Subclass	Date	Examiner
381	105	3/29/06	57
381	104	3/29/06	02
381	106	3/29/02	5-2
381	102	3/29/02	57
381	311	3/31/07	17
		/ /	`
:			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

_	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
Assigned/Inventor Search		D7		
Comband Class/word segrets 381/102-109	3/2/07	87		